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# ***Systems Contamination: Prediction, Control, and Performance 2020***

**Carlos E. Soares**  
**Eve M. Wooldridge**  
**Bruce A. Matheson**  
*Editors*

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# Contents

---

## CONTAMINATION CONTROL AND PLANETARY PROTECTION FOR SPACE MISSIONS I

---

- 11489 03 **Mars 2020: mission, science objectives and build (Invited Paper)** [11489-1]
- 11489 04 **Predicting terrestrial contamination of the Mars 2020 sample caching system with novel multispecies outgassing and transport models** [11489-2]
- 11489 07 **The role of purged bakeout method in achieving the required cleanliness for the polarimetric and helioseismic imager on the Solar Orbiter mission** [11489-5]

---

## CONTAMINATION CONTROL AND PLANETARY PROTECTION FOR SPACE MISSIONS II

---

- 11489 0A **Developments on the instrument performance predictions and contamination modelling: the practical approach of ESA's Sentinel-4 mission** [11489-8]
- 11489 0B **NASA's planetary protection policies revised in response to changes in space exploration** [11489-9]

---

## SPACE SYSTEMS CONTAMINATION ANALYSIS AND MODELING I

---

- 11489 0C **CFD and DSMC methods for tracking gases and droplets behaviors within the plume** [11489-10]
- 11489 0D **Space launch vehicle transient particle redistribution modeling and implications for optically sensitive payloads** [11489-11]
- 11489 0E **A new dynamic outgassing procedure to predict reemission and deposition values of contaminants** [11489-12]
- 11489 0F **Desorption, diffusion, reflections, and reemission: the outgassing molecules elusive behaviors** [11489-13]
- 11489 0G **Species separation of molecular contamination from space materials by QTGA/MS** [11489-14]

---

## SPACE SYSTEMS CONTAMINATION ANALYSIS AND MODELING II

---

- 11489 0H **Optimization, development, and validation of the contamination transport simulation code** [11489-15]

11489 OK **Particulate and molecular contamination control in EUV-induced H<sub>2</sub>-plasma in EUV lithographic scanner** [11489-18]

---

**CONTAMINATION CONTROL PRACTICES AND APPLICATIONS TO SPACE SYSTEMS I**

---

11489 OM **In-situ measurement technique of contamination morphology under vacuum and low temperature condition** [11489-20]

11489 ON **Evaluation of protection films for optics in space industry** [11489-21]

11489 OO **Micro Raman spectroscopy for characterizing molecular contamination on space flight hardware** [11489-22]

11489 OQ **Particle deposition rate application in system contamination control** [11489-24]

---

**CONTAMINATION CONTROL PRACTICES AND APPLICATIONS TO SPACE SYSTEMS II**

---

11489 OS **Mass decrease in contaminants by photocatalytic decomposition of TiO<sub>2</sub> in vacuum** [11489-26]

---

**NEW SUBMISSIONS**

---

11489 OT **Preparing for Mars 2020 and future space missions: technology advancements driving contamination control requirements and cleanroom protocols** [11489-27]